

**Search Notes**

Application/Control No.

10/674,102

Examiner

Mark Hellner

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

3663

**SEARCHED**

Class	Subclass	Date	Examiner
359	349 341.3 341.32	09/04/06	MAU

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference Search	09/04/06	MAU